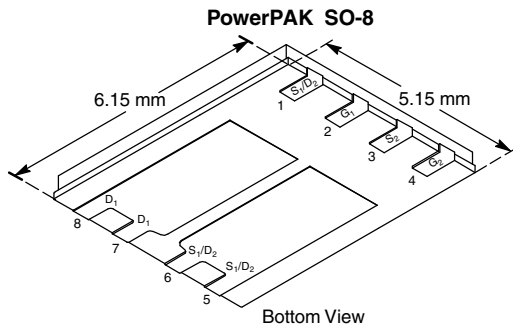


Dual N-Channel 20 V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY				
	V_{DS}	$R_{DS(on)}$ (Ω)	I_D (A) ^{a, f}	Q_g (Typ.)
Channel-1	20	0.022 at $V_{GS} = 10$ V	8	8
		0.025 at $V_{GS} = 4.5$ V	8	
Channel-2	20	0.015 at $V_{GS} = 10$ V	8	17
		0.019 at $V_{GS} = 4.5$ V	8	

SCHOTTKY PRODUCT SUMMARY		
V_{DS} (V)	V_{SD} (V) Diode Forward Voltage	I_F (A) ^a
20	0.43 V at 1 A	4



Ordering Information:
Si7980DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

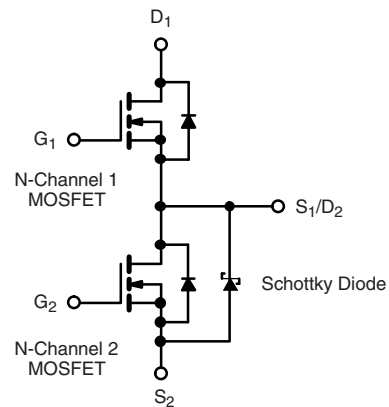
- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested
- Material categorization:
For definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Synchronous Buck Converter
 - Game Machines
 - Notebook Computers



ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)				
Parameter	Symbol	Channel-1	Channel-2	Unit
Drain-Source Voltage	V_{DS}	20	20	V
Gate-Source Voltage	V_{GS}	± 16	± 16	
Continuous Drain Current ($T_J = 150$ °C)	I_D	$T_C = 25$ °C	8^f	A
		$T_C = 70$ °C	8^f	
		$T_A = 25$ °C	$8.8^{b, c}$	
		$T_A = 70$ °C	$7.1^{b, c}$	
Pulsed Drain Current	I_{DM}	30	30	A
Source-Drain Current Diode Current	I_S	$T_C = 25$ °C	8^f	
		$T_A = 25$ °C	$2.8^{b, c}$	
Pulsed Source-Drain Current	I_{SM}	30	30	A
Single Pulse Avalanche Current	I_{AS}	15	15	
Single Pulse Avalanche Energy	E_{AS}	11.2	11.2	mJ
Maximum Power Dissipation	P_D	$T_C = 25$ °C	19.8	W
		$T_C = 70$ °C	12.6	
		$T_A = 25$ °C	$3.1^{b, c}$	
		$T_A = 70$ °C	$2^{b, c}$	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150		°C
Soldering Recommendations (Peak Temperature) ^{d, e}		260		

Notes:

- Based on $T_C = 25$ °C.
- Surface mounted on 1" x 1" FR4 board.
- $t = 10$ s.
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Package limited.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Channel-1		Channel-2		Unit
		Typ.	Max.	Typ.	Max.	
Maximum Junction-to-Ambient ^{a, b}	R_{thJA}	32	40	30	36	°C/W
Maximum Junction-to-Case (Drain)	R_{thJC}	5	6.3	4.5	5.7	

SPECIFICATIONS ($T_J = 25\text{ °C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ. ^c	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch-1	20		V	
		$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	Ch-2	20			
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch-1		22	mV/°C	
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch-1		- 5		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch-1	1		2.5	
		$V_{DS} = V_{GS}, I_D = 1\text{ mA}$	Ch-2	1.4		2.8	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 16\text{ V}$	Ch-1			100	
		$V_{DS} = 0\text{ V}, V_{GS} = \pm 16\text{ V}$	Ch-2			100	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$	Ch-1			0.001	
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$	Ch-2		0.05	0.50	
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, T_J = 100\text{ °C}$	Ch-1			0.025	
		$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, T_J = 100\text{ °C}$	Ch-2		3	15	
On-State Drain Current ^d	$I_{D(on)}$	$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$	Ch-1	10		A	
		$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$	Ch-2	10			
Drain-Source On-State Resistance ^d	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 5\text{ A}$	Ch-1		0.018	0.022	
		$V_{GS} = 10\text{ V}, I_D = 5\text{ A}$	Ch-2		0.012	0.015	
		$V_{GS} = 4.5\text{ V}, I_D = 4\text{ A}$	Ch-1		0.020	0.025	
		$V_{GS} = 4.5\text{ V}, I_D = 4\text{ A}$	Ch-2		0.015	0.019	
Forward Transconductance ^d	g_{fs}	$V_{DS} = 15\text{ V}, I_D = 5\text{ A}$	Ch-1		40	S	
		$V_{DS} = 15\text{ V}, I_D = 5\text{ A}$	Ch-2		47		
Dynamic^c							
Input Capacitance	C_{iss}	Channel-1 $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	Ch-1		1010	pF	
			Ch-2		1370		
Output Capacitance	C_{oss}		Channel-2 $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	Ch-1			220
				Ch-2			320
Reverse Transfer Capacitance	C_{rss}	Ch-1			100		
		Ch-2			120		

Notes:

- Surface mounted on 1" x 1" FR4 board.
- Maximum under steady state conditions is 88 °C/W (channel-1) and 83 °C/W (channel-2).
- Guaranteed by design, not subject to production testing.
- Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.



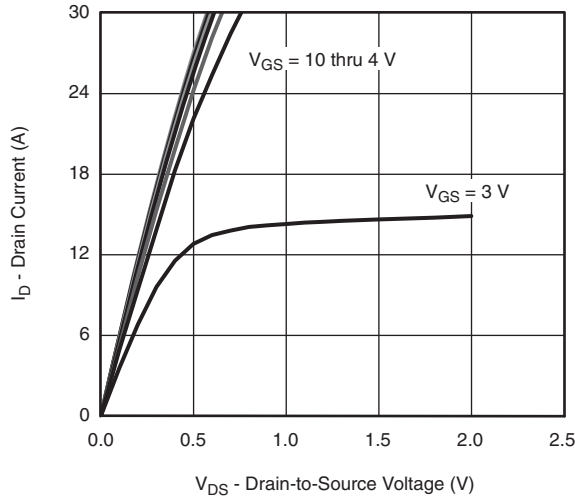
SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit	
Dynamic^a							
Total Gate Charge	Q_g	$V_{DS} = 10\text{ V}, V_{GS} = 10\text{ V}, I_D = 5\text{ A}$	Ch-1		17.5	27	nC
		$V_{DS} = 10\text{ V}, V_{GS} = 10\text{ V}, I_D = 5\text{ A}$	Ch-2		22.5	34	
Gate-Source Charge	Q_{gs}	Channel-1 $V_{DS} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 5\text{ A}$	Ch-1		8	12	
			Ch-2		10.3	16	
		Channel-2 $V_{DS} = 10\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 5\text{ A}$	Ch-1		2.5		
			Ch-2		3.4		
Gate-Drain Charge	Q_{gd}		Ch-1		2.1		
			Ch-2		2.6		
Gate Resistance	R_g	$f = 1\text{ MHz}$	Ch-1	0.2	1.1	2.2	Ω
			Ch-2	0.2	1.3	2.6	
Turn-On Delay Time	$t_{d(on)}$	Channel-1 $V_{DD} = 10\text{ V}, R_L = 2\text{ }\Omega$ $I_D \cong 5\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$	Ch-1		9	18	ns
Rise Time	t_r		Ch-2		13	25	
Turn-Off Delay Time	$t_{d(off)}$	Channel-2 $V_{DD} = 10\text{ V}, R_L = 2\text{ }\Omega$ $I_D \cong 5\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$	Ch-1		16	30	
			Ch-2		16	30	
Fall Time	t_f		Ch-1		20	35	
			Ch-2		24	45	
Turn-On Delay Time	$t_{d(on)}$	Channel-1 $V_{DD} = 10\text{ V}, R_L = 2\text{ }\Omega$ $I_D \cong 5\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$	Ch-1		9	18	
			Ch-2		8	16	
Rise Time	t_r		Ch-1		15	30	
			Ch-2		18	35	
Turn-Off Delay Time	$t_{d(off)}$	Channel-2 $V_{DD} = 10\text{ V}, R_L = 2\text{ }\Omega$ $I_D \cong 5\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$	Ch-1		18	35	
			Ch-2		18	35	
Fall Time	t_f		Ch-1		20	40	
			Ch-2		25	45	
			Ch-1		12	24	
			Ch-2		10	20	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	Ch-1			8	A
			Ch-2			8	
Pulse Diode Forward Current ^a	I_{SM}		Ch-1			30	
			Ch-2			30	
Body Diode Voltage	V_{SD}	$I_S = 2\text{ A}$	Ch-1		0.73	1.1	V
		$I_S = 1\text{ A}$	Ch-2		0.37	0.43	
Body Diode Reverse Recovery Time	t_{rr}		Ch-1		16	32	ns
			Ch-2		20	40	
Body Diode Reverse Recovery Charge	Q_{rr}	Channel-1 $I_F = 5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	Ch-1		8	16	nC
			Ch-2		10	20	
Reverse Recovery Fall Time	t_a	Channel-2 $I_F = 5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	Ch-1		8		ns
			Ch-2		9		
Reverse Recovery Rise Time	t_b		Ch-1		8		
			Ch-2		11		

Note:

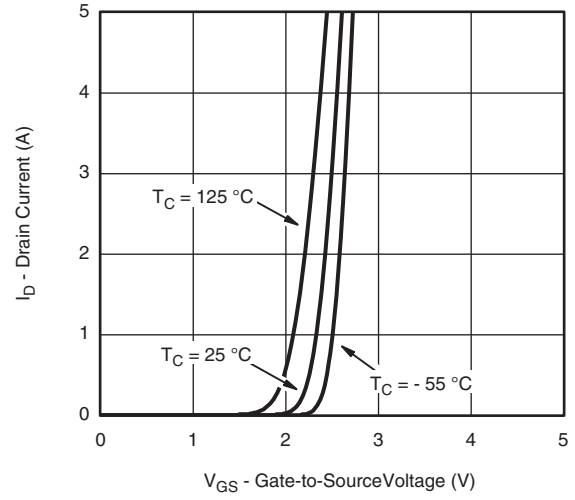
a. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

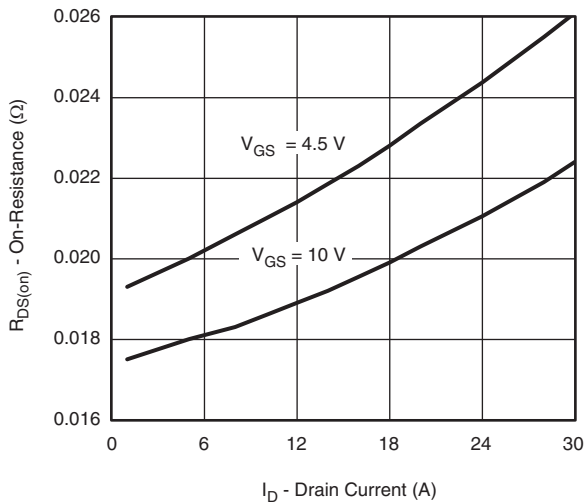
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



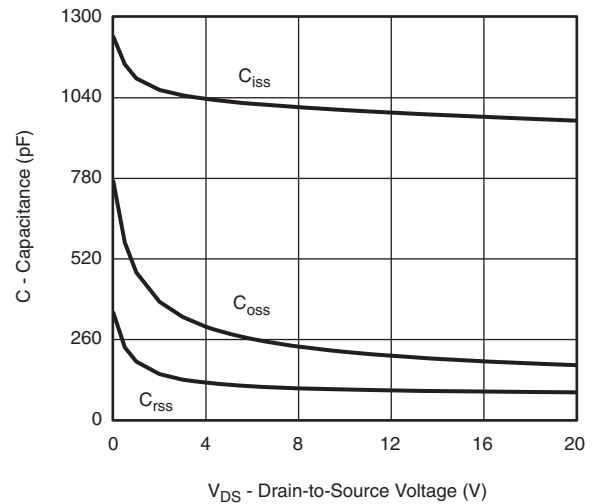
Output Characteristics



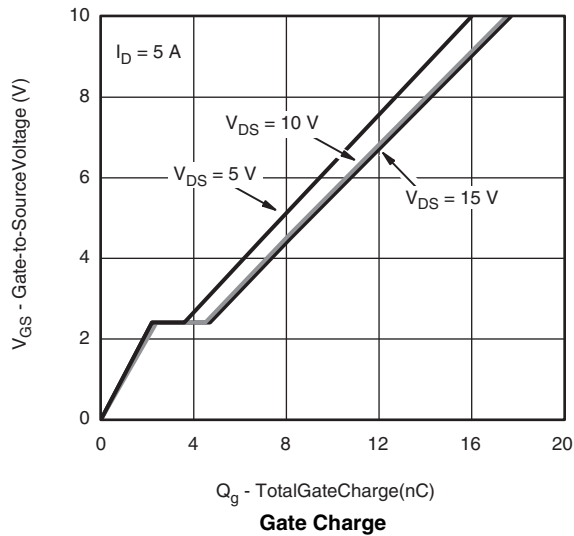
Transfer Characteristics



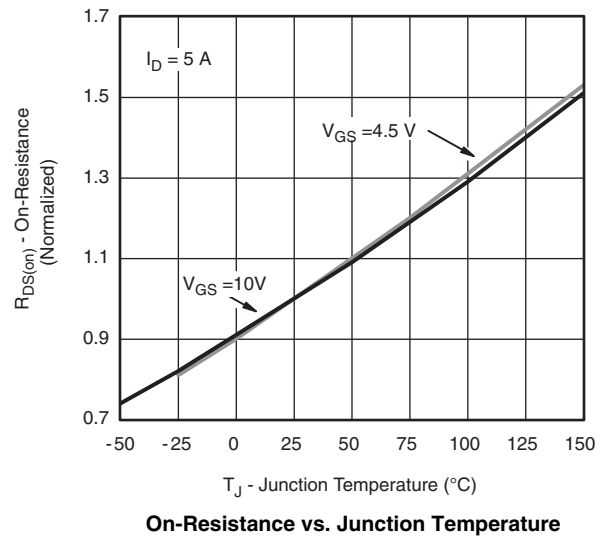
On-Resistance vs. Drain Current



Capacitance

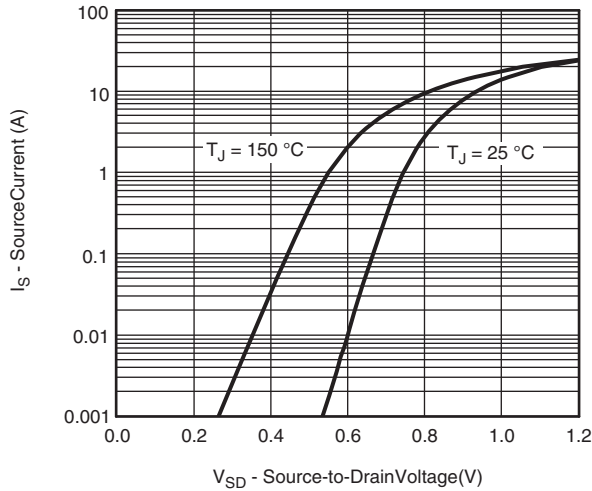


Gate Charge

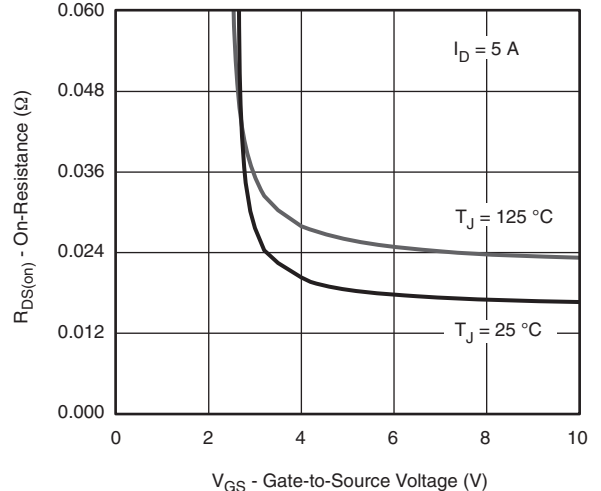


On-Resistance vs. Junction Temperature

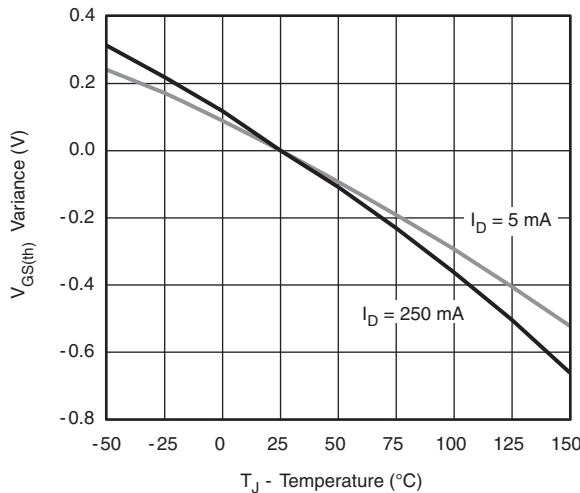
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



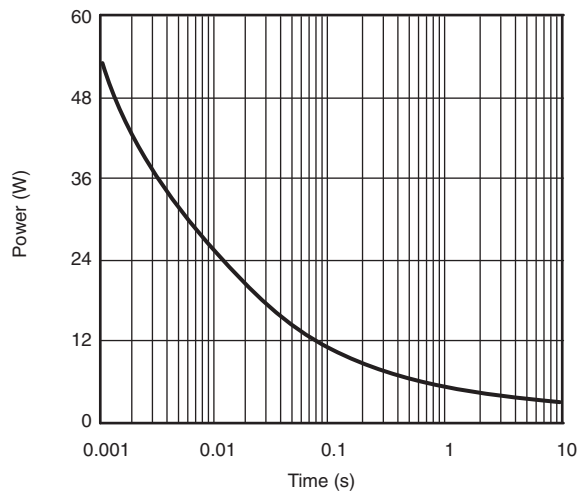
Source-Drain Diode Forward Voltage



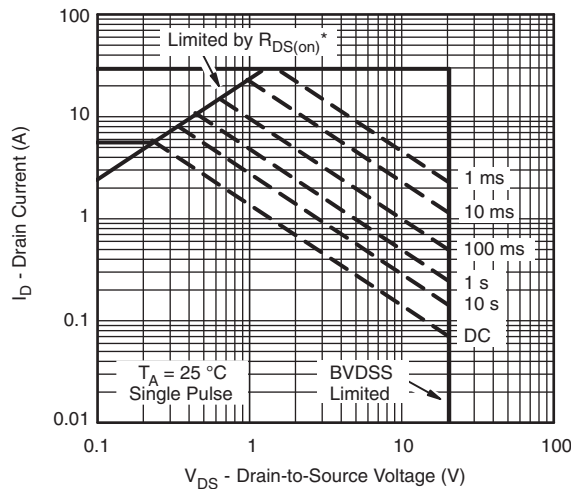
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



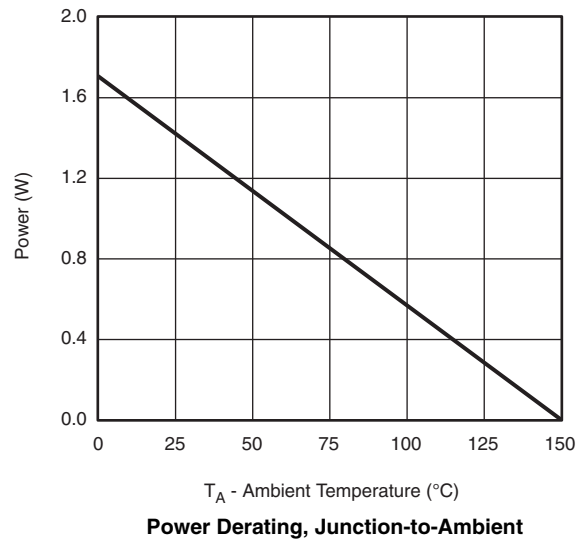
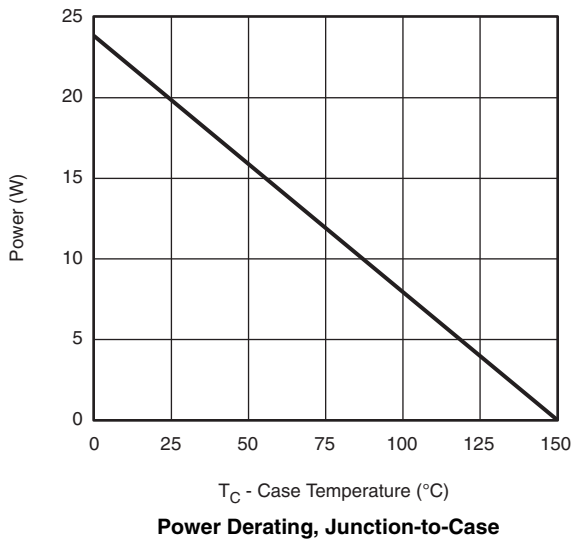
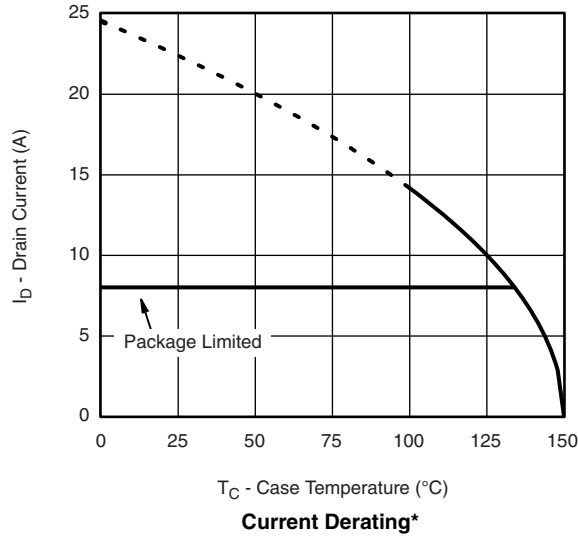
Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

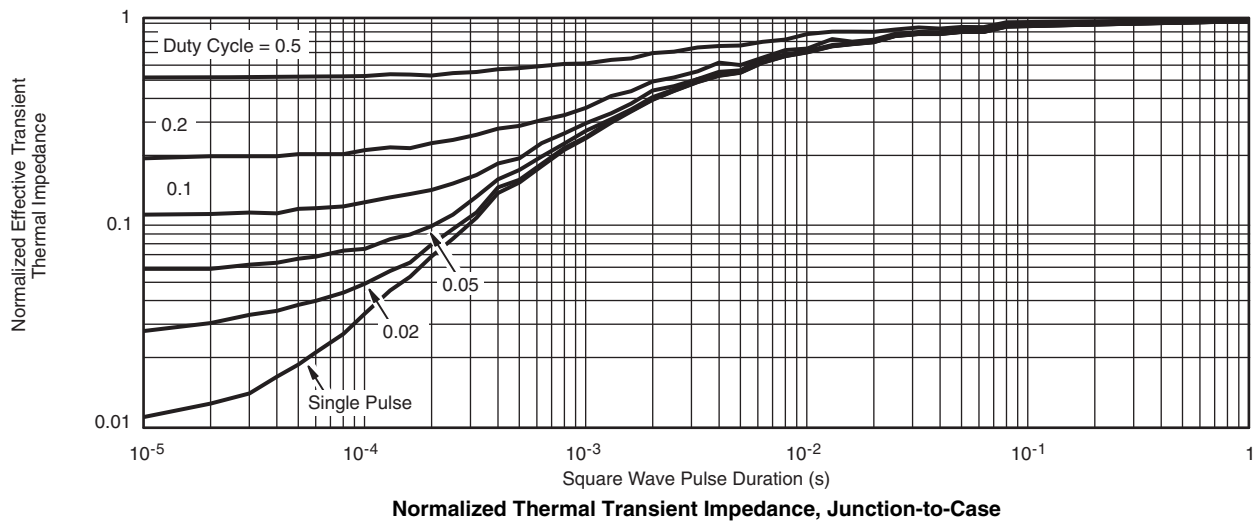
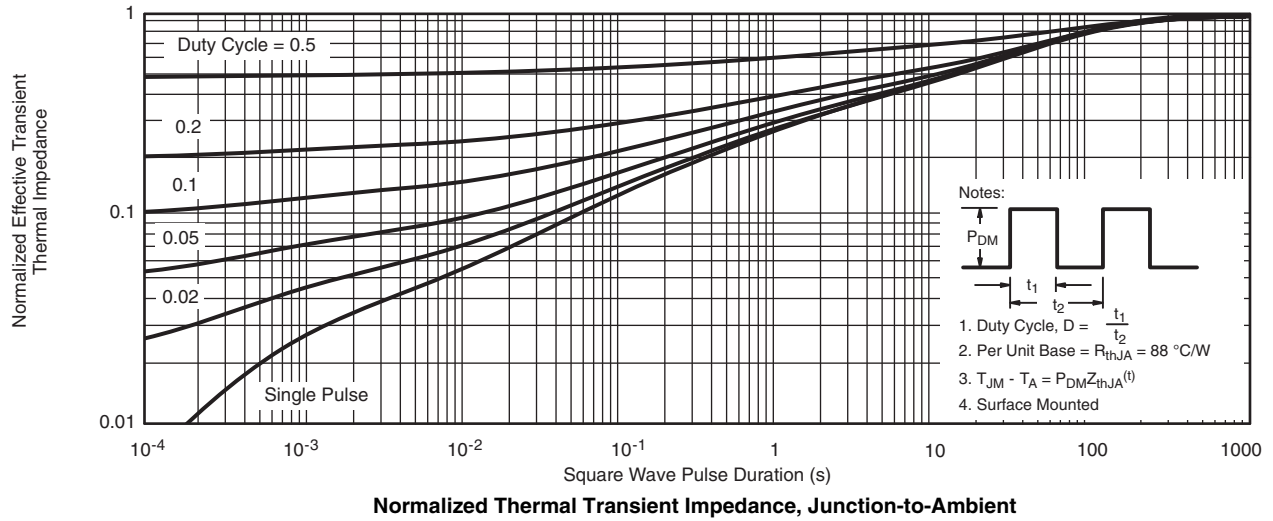
Safe Operating Area, Junction-to-Ambient

CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

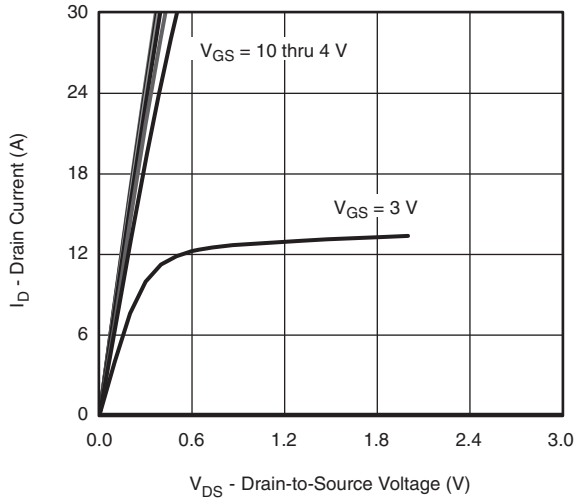


* The power dissipation P_D is based on $T_{J(max.)} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

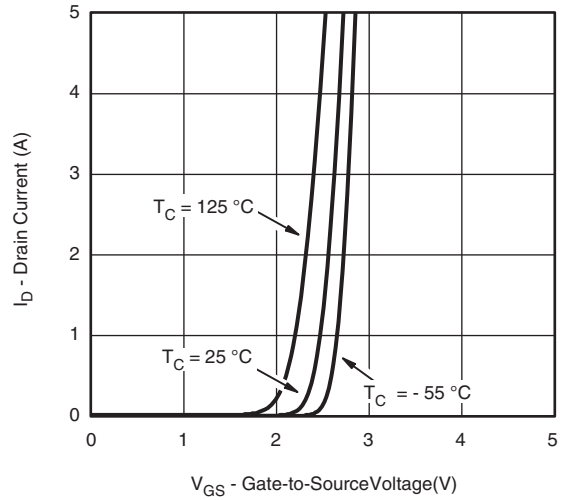
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



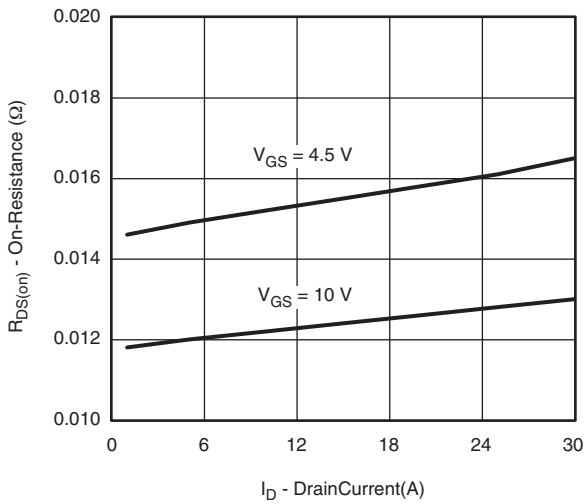
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



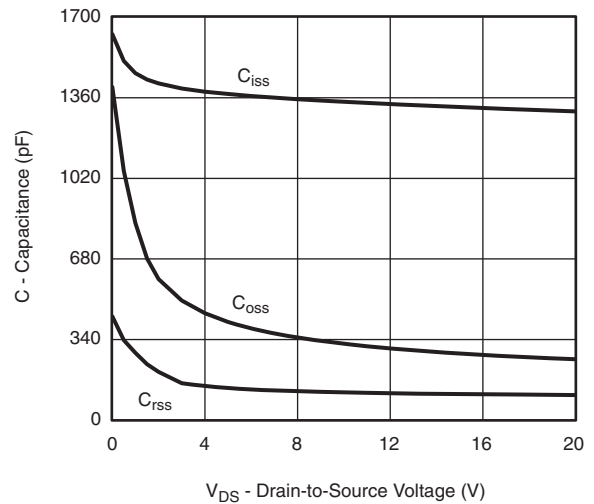
Output Characteristics



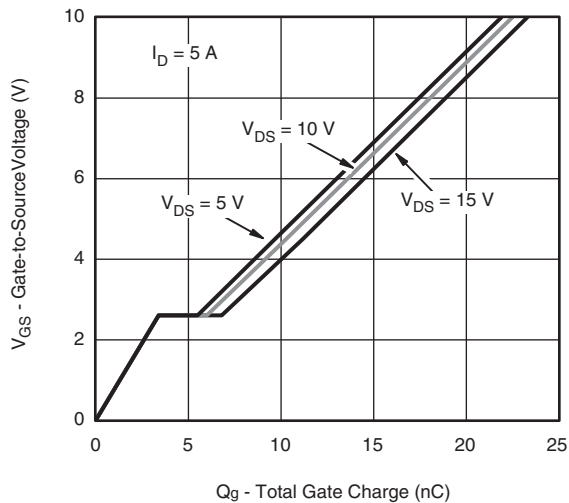
Transfer Characteristics



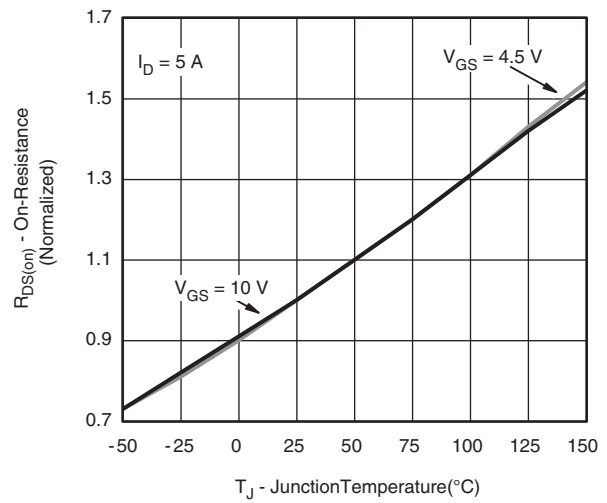
On-Resistance vs. Drain Current



Capacitance

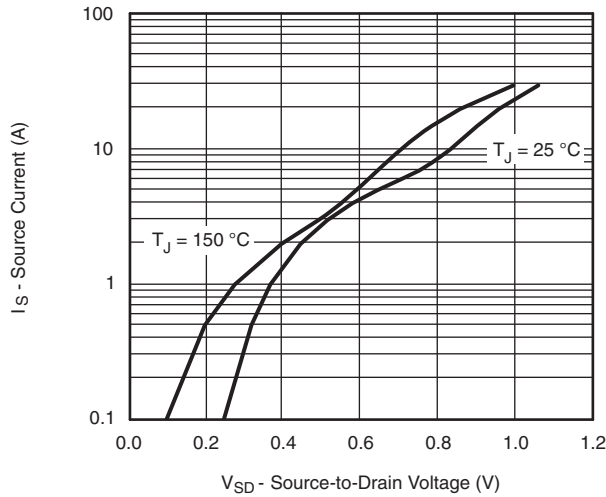


Gate Charge

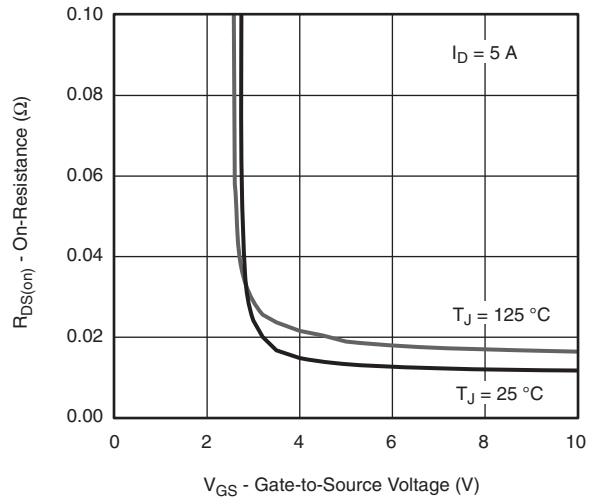


On-Resistance vs. Junction Temperature

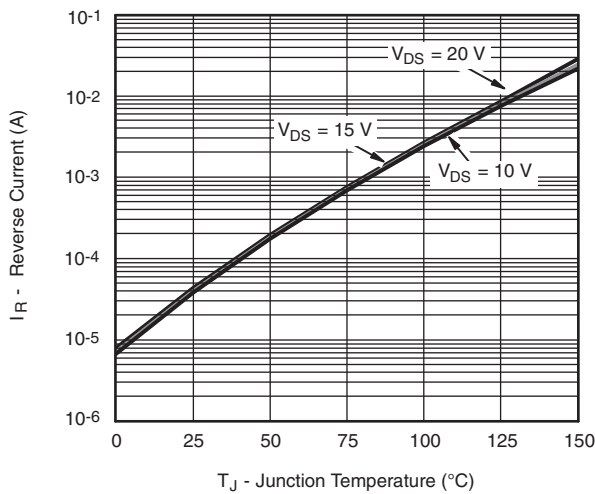
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



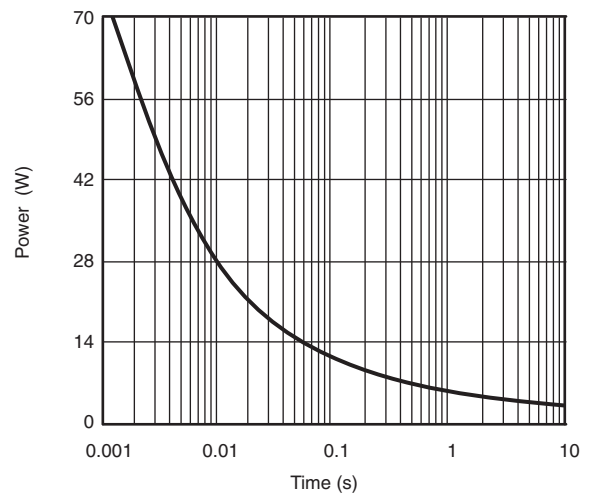
Source-Drain Diode Forward Voltage



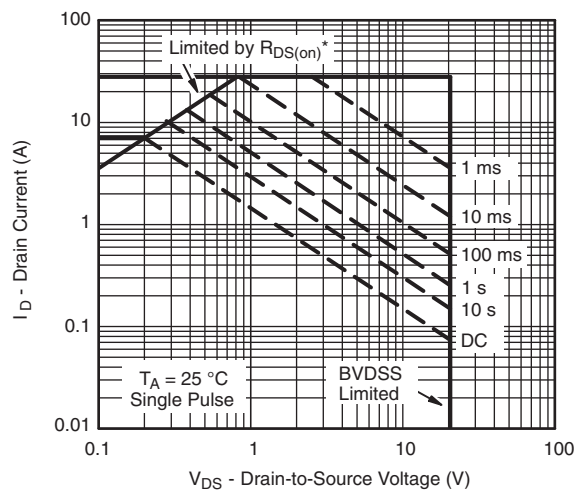
On-Resistance vs. Gate-to-Source Voltage



Reverse Current (Schottky)



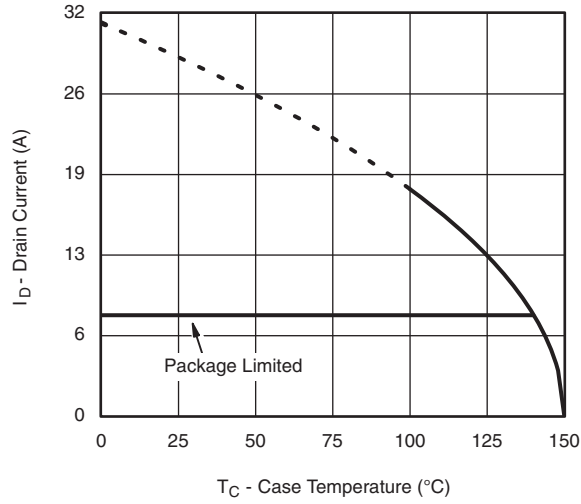
Single Pulse Power, Junction-to-Ambient



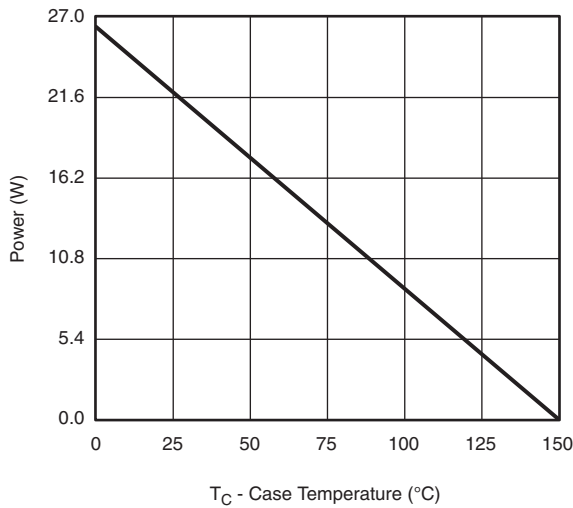
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

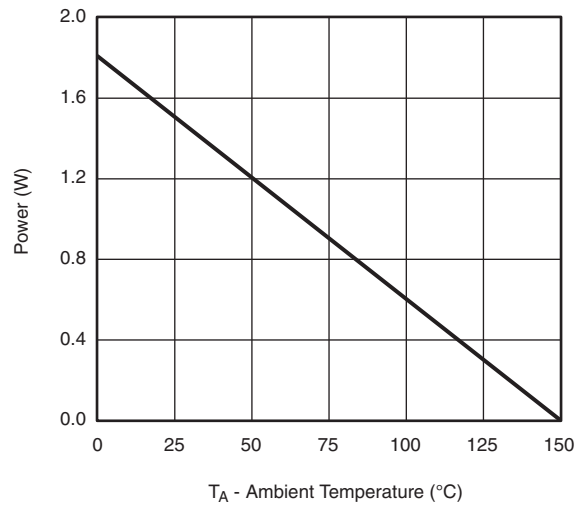
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



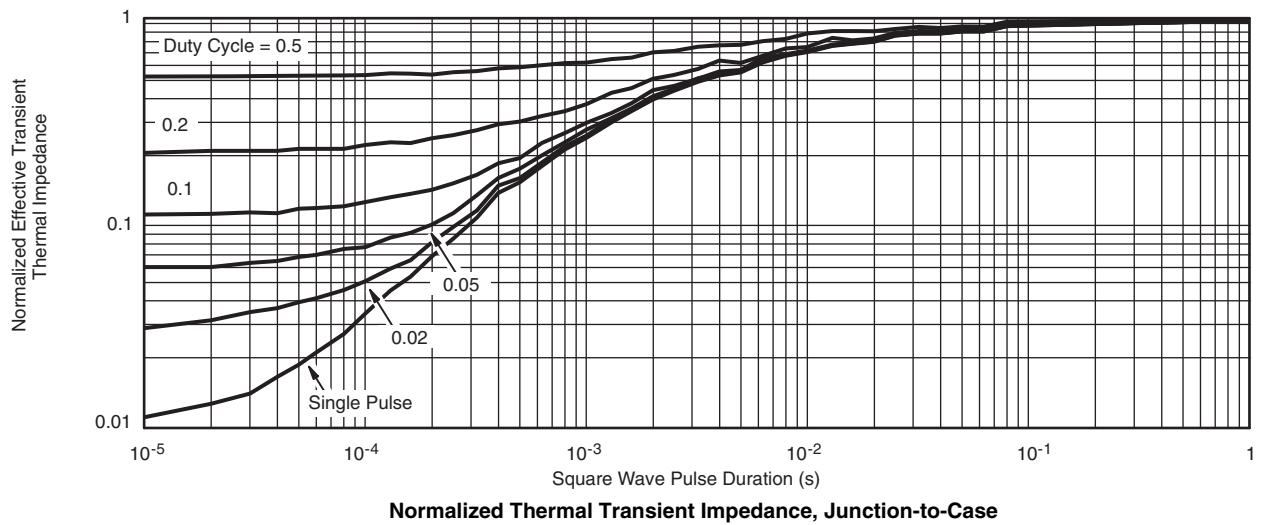
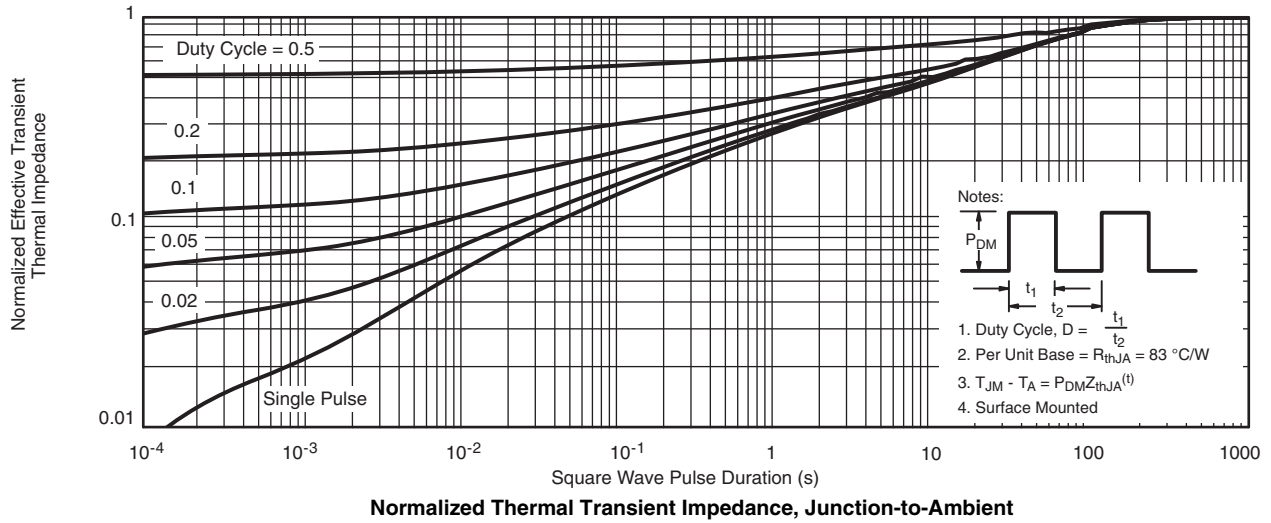
Power Derating, Junction-to-Case



Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

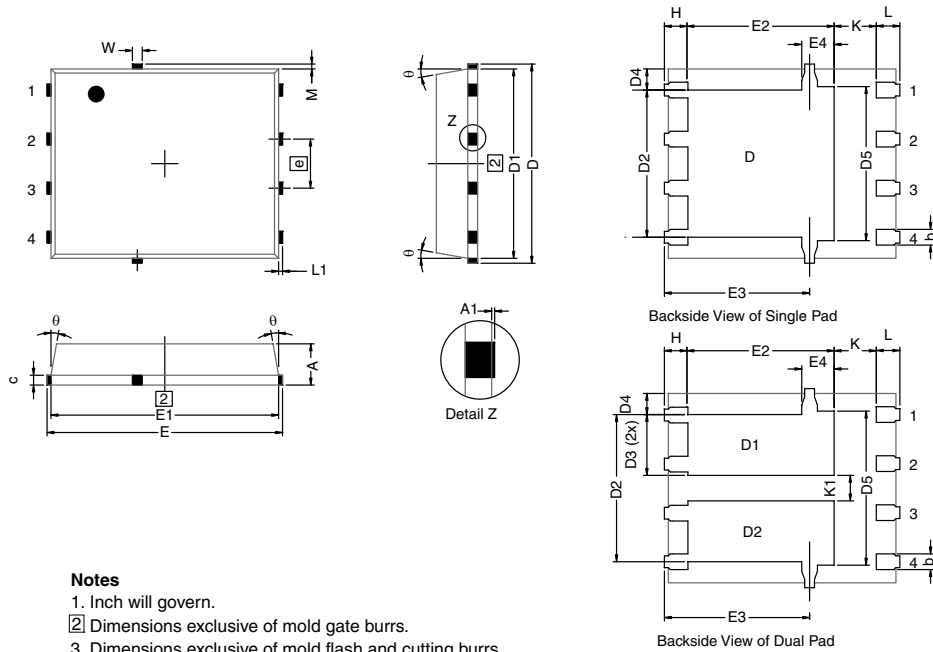
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?68391.



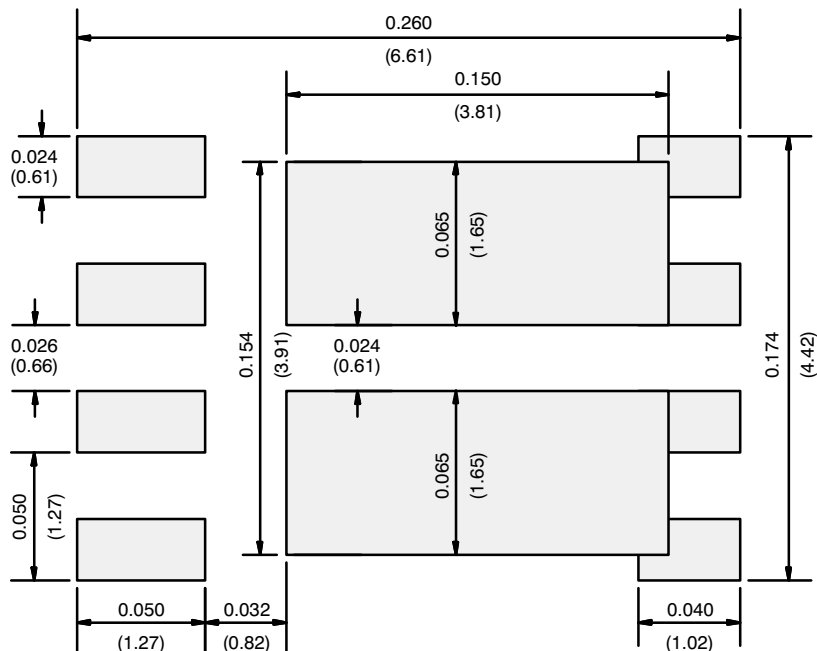
PowerPAK[®] SO-8, (Single/Dual)



- Notes**
1. Inch will govern.
 2. Dimensions exclusive of mold gate burrs.
 3. Dimensions exclusive of mold flash and cutting burrs.

DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.97	1.04	1.12	0.038	0.041	0.044
A1		-	0.05	0	-	0.002
b	0.33	0.41	0.51	0.013	0.016	0.020
c	0.23	0.28	0.33	0.009	0.011	0.013
D	5.05	5.15	5.26	0.199	0.203	0.207
D1	4.80	4.90	5.00	0.189	0.193	0.197
D2	3.56	3.76	3.91	0.140	0.148	0.154
D3	1.32	1.50	1.68	0.052	0.059	0.066
D4	0.57 typ.			0.0225 typ.		
D5	3.98 typ.			0.157 typ.		
E	6.05	6.15	6.25	0.238	0.242	0.246
E1	5.79	5.89	5.99	0.228	0.232	0.236
E2 (for AL product)	3.30	3.48	3.66	0.130	0.137	0.144
E2 (for other product)	3.48	3.66	3.84	0.137	0.144	0.151
E3	3.68	3.78	3.91	0.145	0.149	0.154
E4 (for AL product)	0.58 typ.			0.023 typ.		
E4 (for other product)	0.75 typ.			0.030 typ.		
e	1.27 BSC			0.050 BSC		
K (for AL product)	1.45 typ.			0.057 typ.		
K (for other product)	1.27 typ.			0.050 typ.		
K1	0.56	-	-	0.022	-	-
H	0.51	0.61	0.71	0.020	0.024	0.028
L	0.51	0.61	0.71	0.020	0.024	0.028
L1	0.06	0.13	0.20	0.002	0.005	0.008
θ	0°	-	12°	0°	-	12°
W	0.15	0.25	0.36	0.006	0.010	0.014
M	0.125 typ.			0.005 typ.		
ECN: C13-0702-Rev. K, 20-May-13						
DWG: 5881						

RECOMMENDED MINIMUM PADS FOR PowerPAK® SO-8 Dual



Recommended Minimum Pads
Dimensions in Inches/(mm)

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